

Q-2 (H) Paper-IV

### Junction Field-Effect Transistor (JFET)

Fig shows a junction field effect transistor. It consists of a uniformly doped semiconductor bar with ohmic contacts at both ends and with semiconductor junctions on both sides of the bar.

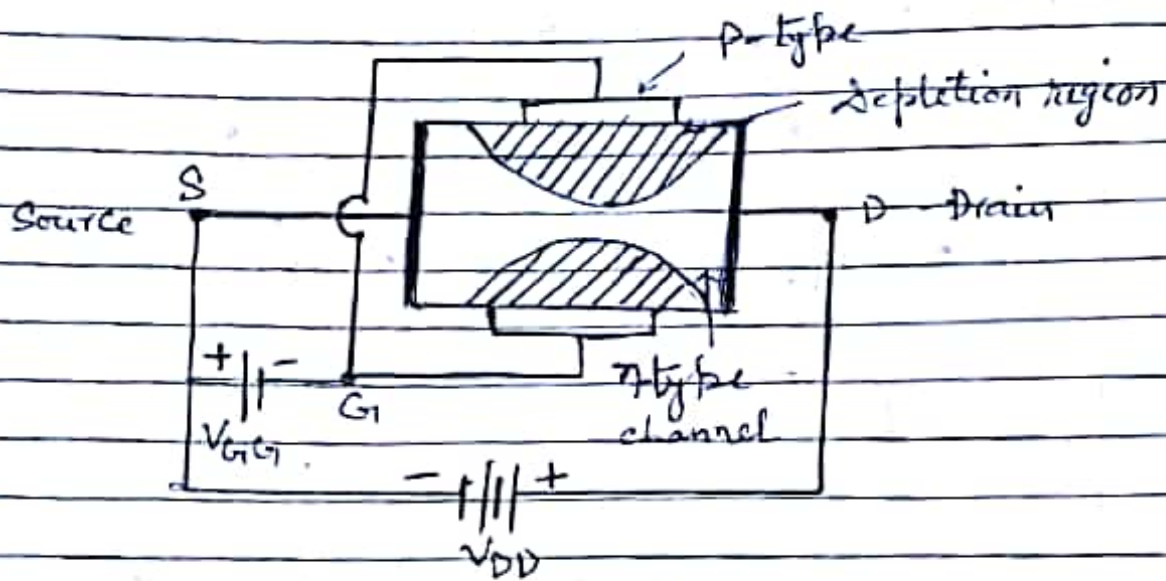


Fig. 1 A JFET

For n-type bar the FET is n-channel FET and for p-type, it is called p-channel FET. Current is allowed to flow by applying a voltage between the end terminals of the bar. The current is carried by majority carriers. The different notations in the fig are :-

S (Source) :- The terminal through which the majority carriers ~~enter~~ <sup>enter</sup> the channel is called the source.

D (Drain) :- The terminal through which the majority carriers leave the channel is called the drain.

G<sub>1</sub> (Gate) :- On both sides of the doped semiconductor bar heavily doped regions are formed by allowing, diffusion or by other techniques using impurities opposite to that of the channel. These regions are called the gate.

The circuit symbol of n-type & p-type FET are shown in fig.

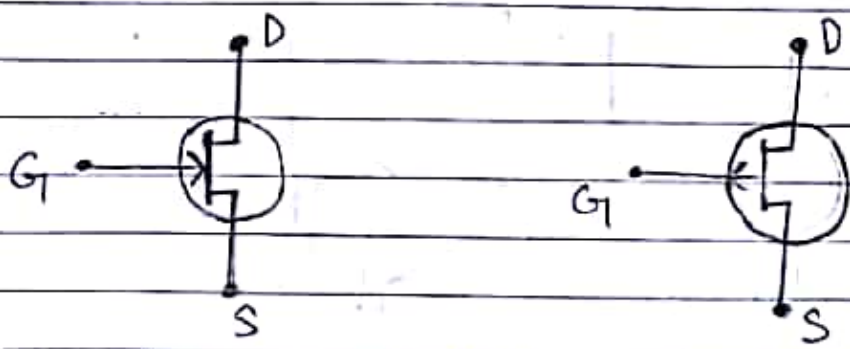
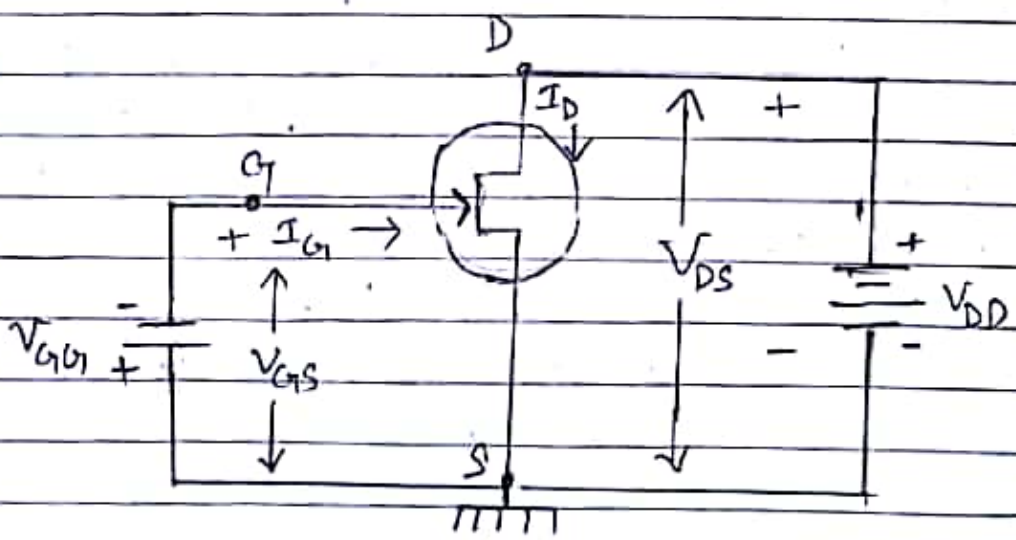


fig.2 (a) n-channel FET (b) p-channel FET

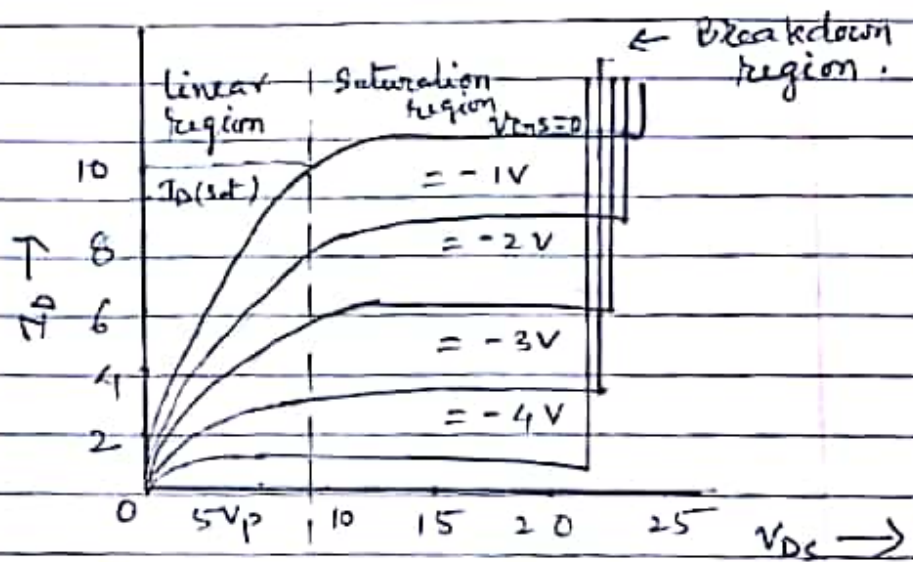
An n-channel FET with its terminal connected to voltage sources is shown in fig.1 and also schematically in fig.3. The voltage  $V_{GS}$  &  $V_{DS}$  respectively supply the gate voltage & the drain voltage.



n-channel - FET

Principle of Operation :- When the junction between the gate & the source is reverse-biased, there will be depletion region on both sides of the channel. The depletion regions contain only immobile charges and no free carriers, therefore the conductivity of these regions will be practically zero. For a fixed drain to source voltage the drain current will be a fn. of the gate to source voltage.

Static characteristic :- (i) The graphical plots of  $I_D$  against  $V_{DS}$  with  $V_{GS}$  as a parameter are termed as static characteristic of the FET.



Linear region, where  $I_D$  is const.  $V_{DS}$  is small and  $I_D$  is proportional to  $V_{DS}$ .

(ii) Saturation region, where  $I_D$  is const. and is independent of  $V_{DS}$  and

(iii) Breakdown region, where  $I_D$  rises with a slight increase of the  $V_{DS}$ .

To explain these features let us consider  $V_{GS} = 0$ . When voltage  $V_{DS}$  is increased from 0 to a small amount the n-channel bar acts as a simple resistor, hence  $I_D$  increases linearly with  $V_{DS}$  in this region. With increasing  $V_{DS}$ , the characteristic bends, and finally at a value  $V_{DS}$



the voltage  $V_{DS}$  the current  $I_D$  saturates at a value  $(I_D)_{sat}$ .

The channel is now said to be pinched off, and the voltage  $V_p$  is called pinched off voltage. Breakdown occurs at a lower value of  $V_{DS}$  when the magnitude of the reverse bias voltage  $V_{GS}$  is increased.

Transfer characteristic :- It gives the variation of  $(I_D)_{sat}$  with  $V_{GS}$ .

